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Neural Networks Proceedings, 1998. IEEE World Congress on Computational Intelligence. The 1998 IEEE International Joint Conference on , Volume: 1 , 4 May 1998

Pages:593 - 597 vol.1

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Robe, T.J.; Walsh, K.A.;

Selected Areas in Communications, IEEE Journal on , Volume: 9 , Issue: 5 , Ju 1991

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Custom Integrated Circuits Conference, 1995., Proceedings of the IEEE 1995 May 1995

Pages:427 - 430

[\[Abstract\]](#)   [\[PDF Full-Text \(520 KB\)\]](#)   **IEEE CNF****2 A SONET STS-3c user network interface integrated circuit***Robe, T.J.; Walsh, K.A.;*

Selected Areas in Communications, IEEE Journal on , Volume: 9 , Issue: 5 , Ju 1991

Pages:732 - 740

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